## Notice of References Cited Application/Control No. 10/811,408 Examiner Jason L. Lazorcik Applicant(s)/Patent Under Reexamination STARK, DAVID H. Page 1 of 1

## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-3,410,674	11-1968	MARTIN FRANCIS W	65/33.5
	В	US-			
	С	US-			
	D	US-			<u> </u>
	Е	US-			
	F	US-			
	G	US-			
	Н	US-			
	1	US-			
	J	US-			
	К	US-			
	٦	US-			
	М	US-			

## **FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	Q					
	R					
	s					
	Т					

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Bayrashev, A., Ziaie, B., "Silicon wafer bonding through RF dielectric heating", Sensors and Actuators A: Physical, Volume 103, Issues 1-2, 15 January 2003, Pages 16-22. Relevant text see page 21, column 2, paragraph 2
	٧	"Pyrex", (Http://en.wikipedia.org/wiki/Pyrex) Accessed October 11, 2006
	w	
	x	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.